

## N THE UNITED STATES PATENT AND TRADEMARK OFFICE

ore Patent Application of

Allan Rosencwaig et al.

Application No.: 09/629,407

Filed: August 1, 2000

For: MEASUREMENT OF THIN FILMS

AND BARRIER LAYERS ON

PATTERNED WAFERS WITH X-RAY

REFLECTOMETRY

Group Art Unit: 2876

Examiner:

SECOND SUPPLEMENTAL INFORMATION DISCLOSURI STATEMENT

121 Spear Street, Suite 290 San Francisco, CA 94105 (415) 512-1312

CERTIFICATE OF MAILING

I hereby certify that this correspondence is being deposited with the United States Postal Service as First Class Mail in an envelope, addressed to: Commissioner for Patents, Washington, DC 20231 on April 18. 2002.

STALLMAN & POLLOCK ĻLP

Dated: 04/18/2002 By

Lorgia T

Commissioner for Patents Washington, D.C. 20231

Sir:

Applicants submit herewith patents, publications or other information [attached hereto and listed on the attached Form PTO-1449 (modified)] of which they are aware, which they believe may be material to the examination of this application and in respect of which there may be a duty to disclose in accordance with 37 CFR § 1.56.

This Information Disclosure Statement:

- (a) accompanies the new patent application submitted herewith. 37 CFR § 1.97(a).
- (b) is filed within three months after the filing date of the application or within three months after the date of entry of the national stage of a PCT application as set forth in 37 CFR § 1.491.
- (c) as far as is known to the undersigned, is filed before the mailing date of a first Office Action on the merits.
- (d) is filed after the first office action and more than three months after the application's filing date or PCT national stage date of entry filing but, as far as is

	known to the undersigned, prior to the mailing date of either a final rejection or a							
	notice of allowance, whichever occurs first, and is accompanied by either the fee							
	(\$240) set forth in 37 CFR § 1.17(p) or a certification as specified in 37 CFR §							
	1.97(e), as checked below.							
(e)	is filed after the mailing date of either a final rejection or a notice of allowance,							
	whichever occurred first, and the Issue Fee has not been paid, and is accompanied							
	by the fee (\$130) set forth in 37 CFR § 1.17(i)(1) and a certification as specified							
	in 37 CFR § 1.97(e), as checked below. This document is to be considered as a							
	petition requesting consideration of the information disclosure statement.							
[If e	either of boxes (d) or (e) are checked above, the following "certification" under 37							
CFR § 1.97	(e) may need to be completed.] The undersigned certifies that:							
<b>(f)</b>	Each item of information contained in the information disclosure statement was							
cite	d in a communication mailed from a foreign patent office in a counterpart foreign							
арр	lication not more than three months prior to the filing of this information disclosure							
state	ement.							
(g)	No item of information contained in this information disclosure statement was							
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app	lication or, to the knowledge of the undersigned after making reasonable inquiry, was							
kno	wn to any individual designated in 37 CFR § 1.56(c) more than three months prior to							
the	filing of this information disclosure statement.							
A li	st of the patent(s) or publication(s) is set forth on the attached Form PTO-1449							
(Modified)	<u>.</u>							
Αc	opy of the items on PTO-1449 (Modified) is supplied herewith:							
(h)	⊠ each (i) □ none (j) □ only those listed below:							
Tho	ose patent(s) or publication(s) which are marked with an asterisk (*) in the attached							
form PTO-	1449 (Modified) are not supplied because they were previously cited by or submitted							
to the Offic	ce in a prior application no, filed and relied upon in							
this applica	ation for an earlier filing date under 35 U.S.C. § 120.							
A c	oncise explanation of relevance of the items listed on form PTO-1449 (Modified) is:							
(k)	⊠ not given							

(l) given for each listed item
(m) given for only non-English language listed item(s) [Required]
(n) is in the form of an English language copy of a Search Report from a foreign
patent office, issued in a counterpart application, which refers to the relevant
portions of the references [copy attached].
The Examiner is reminded that a "concise explanation of the relevance" of the submitted
items "may be nothing more than identification of the particular figure or paragraph of the patent
or publication which has some relation to the claimed invention," MPEP § 609.
While the information and references disclosed in this Information Disclosure Statement
may be "material" pursuant to 37 CFR § 1.56, it is not intended to constitute an admission that
any patent, publication or other information referred to therein is "prior art" for this invention
unless specifically designated as such.
In accordance with 37 CFR § 1.97(g), the filing of this Information Disclosure Statement
shall not be construed to mean that a search has been made or that no other material information
as defined in 37 CFR § 1.56(a) exists. It is submitted that the Information Disclosure Statement
is in compliance with 37 CFR § 1.98 and MPEP § 609 and the Examiner is respectfully
requested to consider the listed references.
The Commissioner is hereby authorized to charge our Deposit Account No. 50-1703 for

 $\boxtimes$ any fees required in connection with the filing of this Information Disclosure Statement. A duplicate copy of this Notice is enclosed for this purpose. In particular, in the event that an Office Action has crossed in the mail with this Information Disclosure Statement, the Commissioner is authorized to charge the above-named deposit account for any fees required pursuant to CFR §§ 1.17(p) or 1.17(i)(1).

Respectfully submitted,

STALLMAN & POLLOCK LLP

Dated: April 18, 2002

Michael A. Stallman Reg. No. 29,444

Attorneys for Applicant(s)

## CGPY OF PAPERS ORIGINALLY FILED

INFORMATION DISCLOSU  O (Uses vergal sheets if new	Docket Number (Optional) . Application Number 1WI-10820 . 09/629,407 Applicant(s) . Allan Rosencwaig et al.						
APR 3 U 2002 2			Filing Date August 1, 2000		Group Art 2876	Group Art Unit 2876	
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## FOREIGN PATENT DOCUMENTS

ļ		DOCUMENT					TRANSLATION	
ı	 Ref	Number	DATE	COUNTRY	CLASS	SUBCLASS	YES	No
	CA	WO 01/71325	09/27/2001	PCT	G01N	23/00		
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## OTHER DOCUMENTS

(Including Author, Title, Date, Pertinent Pages, Etc.)

СВ	E. Lüken et al., "Growth monitoring of W/Si X-ray multilayers by X-ray reflectivity and kinetic ellipsometry," SPIE, Vol. 2253. November 1994, pp. 327-332.	]
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Examiner Date Considered

Examiner: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if

not in conformance and not considered. Include Copy of this form with next communication to applicant.

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